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October 2006

FDS8949

Dual N-Channel Logic Level PowerTrench[®] MOSFET 40V, 6A, 29mΩ

Features

- Max $r_{DS(on)} = 29m\Omega$ at $V_{GS} = 10V$
- Max $r_{DS(on)} = 36m\Omega$ at $V_{GS} = 4.5V$
- Low gate charge
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability
- RoHS compliant



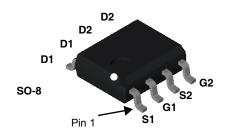
General Description

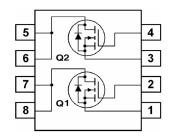
These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Applications

- Inverter
- Power suppliers





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DS}	Drain to Source Voltage		40	V
V_{GS}	Gate to Source Voltage		±20	V
	Drain Current -Continuous (Note 1a		6	۸
ID	-Pulsed		20	A
E _{AS}	Drain-Source Avalanche Energy	(Note 3)	26	mJ
	Power Dissipation for Dual Operation		2	
P_{D}	Power Dissipation for Single Operation	(Note 1a)	1.6	W
		(Note 1b)	0.9	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to 150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance-Single operation, Junction to Ambient	(Note 1a)	81	
$R_{\theta JA}$	Thermal Resistance-Single operation, Junction to Ambient	(Note 1b)	135	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	40	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
FDS8949	FDS8949	13"	12mm	2500 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C		33		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 32V, V _{GS} = 0V			1	μА
.022	Zoro Gato Voltago Brain Garront	T _J = 55°C			10	μΑ
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0\overline{V}$			±100	nA

On Characteristics (Note 2)

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		-4.6		mV/°C
		V_{GS} = 10V, I_D = 6A		21	29	
r _{DS(on)}	Drain to Source On Resistance	V _{GS} = 4.5V, I _D = 4.5A		26	36	mΩ
		V _{GS} = 10V, I _D = 6A,T _J = 125°C		29	43	
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_{D} = 6A$		22		S

Dynamic Characteristics

C _{iss}	Input Capacitance	\\ - 20\\ \\ - 0\\	715	955	pF
C _{oss}	Output Capacitance	V _{DS} = 20V, V _{GS} = 0V, f = 1MHz	105	140	pF
C _{rss}	Reverse Transfer Capacitance	1 - 114112	60	90	pF
R_g	Gate Resistance	f = 1MHz	1.1		Ω

Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time		9	18	ns
t _r	Rise Time	$V_{DD} = 20V, I_{D} = 1A$ $V_{GS} = 10V, R_{GEN} = 6\Omega$	5	10	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10V, K _{GEN} = 052	23	37	ns
t _f	Fall Time		3	6	ns
Q_g	Total Gate Charge		7.7	11	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 20V, I_D = 6A, V_{GS} = 5V$	2.4		nC
Q_{gd}	Gate to Drain "Miller" Charge		2.8		nC

Drain-Source Diode Characteristics and Maximum Ratings

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 6A \text{ (note 2)}$	0.8	1.2	V
t _{rr}	Reverse Recovery Time (note 3)	$I_{\rm F} = 6A$, $d_{\rm iF}/d_{\rm f} = 100A/\mu s$	17	26	ns
Q _{rr}	Reverse Recovery Charge	iF - 0A, α _{iF} /α _t - 100A/μs	7	11	nC

Notes

1: R_{BJA} is the sum of the junction-to-case and case-to- ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BJA} is determined by the user's board design.



a) 81°C/W when mounted on a 1in² pad of 2 oz copper



b) 135°C/W when mounted on a minimum pad .

Scale 1:1 on letter size paper

2: Pulse Test: Pulse Width < 300 us, Duty Cycle < 2.0%.

3: Starting T_J = 25°C, L = 1mH, I_{AS} = 7.3A, V_{DD} = 40V, V_{GS} = 10V.

Typical Characteristics T_J = 25°C unless otherwise noted

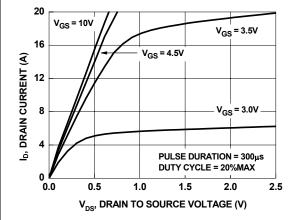


Figure 1. On Region Characteristics

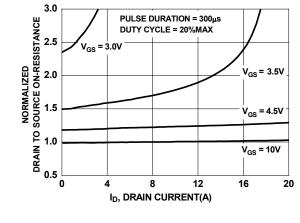


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

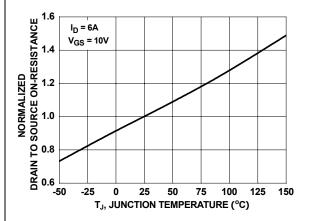


Figure 3. Normalized On Resistance vs Junction Temperature

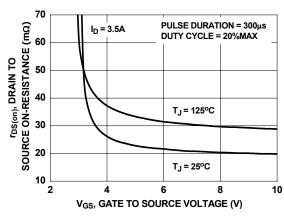


Figure 4. On-Resistance vs Gate to Source Voltage

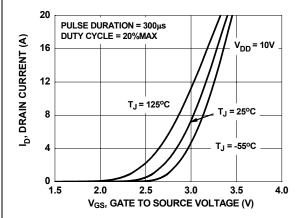


Figure 5. Transfer Characteristics

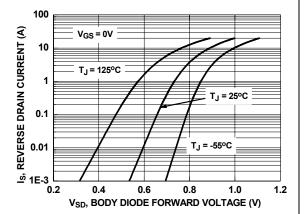


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

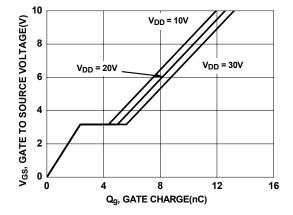
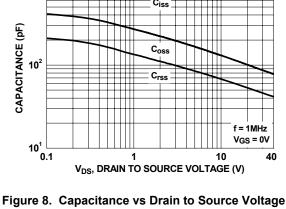


Figure 7. Gate Charge Characteristics



10³

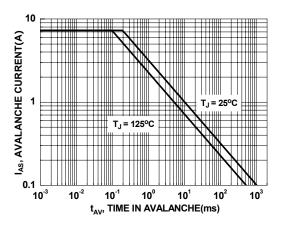


Figure 9. Unclamped Inductive Switching Capability

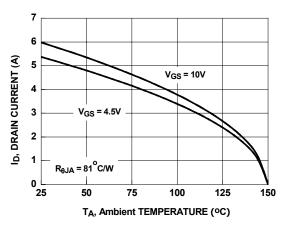


Figure 10. Maximum Continuous Drain Current vs **Ambient Temperature**

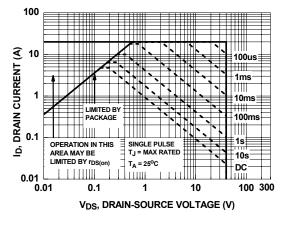


Figure 11. Forward Bias Safe Operating Area

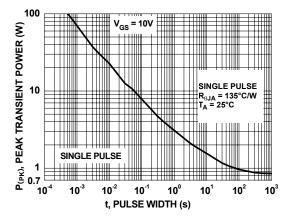


Figure 12. Single Pulse Maximum Power Dissipation

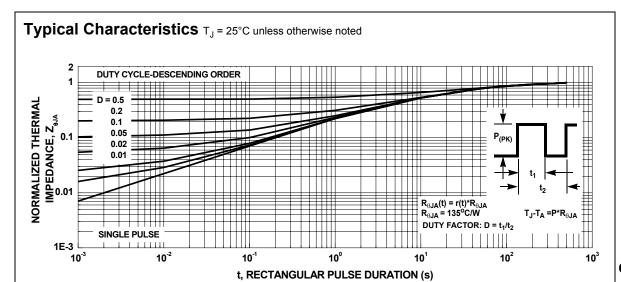


Figure 13. Transient Thermal Response Curve

UniFET™ $\mathsf{UltraFET}^{\circledR}$ VCX^{TM} Wire™

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